

Matched N-Channel JFET Pairs

PRODUCT SUMMARY

Part Number	$V_{GS(off)}$ (V)	$V_{(BR)GSS}$ Min (V)	g_{fs} Min (mS)	I_G Typ (pA)	$ V_{GS1} - V_{GS2} $ Max (mV)
2N5911	-1 to -5	-25	5	-1	10
2N5912	-1 to -5	-25	5	-1	15

FEATURES

- Two-Chip Design
- High Slew Rate
- Low Offset/Drift Voltage
- Low Gate Leakage: 1 pA
- Low Noise
- High CMRR: 85 dB

BENEFITS

- Minimum Parasitics Ensuring Maximum High-Frequency Performance
- Improved Op Amp Speed, Settling Time Accuracy
- Minimum Input Error/Trimming Requirement
- Insignificant Signal Loss/Error Voltage
- High System Sensitivity
- Minimum Error with Large Input Signal

APPLICATIONS

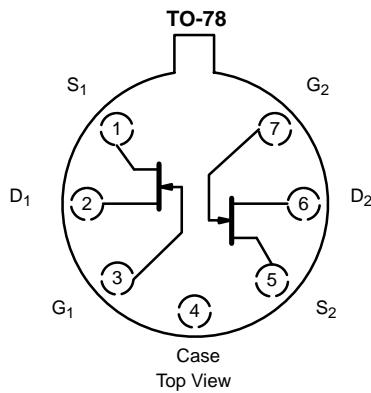
- Wideband Differential Amps
- High-Speed, Temp-Compensated, Single-Ended Input Amps
- High Speed Comparators
- Impedance Converters

DESCRIPTION

The 2N5911/5912 are matched pairs of JFETs mounted in a TO-78 package. This two-chip design reduces parasitics and gives better performance at high frequencies while ensuring extremely tight matching.

For similar products see the SO-8 packaged SST440/SST441, the TO-71 packaged U440/U441, the low-noise SST/U401 series, and the low-leakage U421/423 data sheets.

The hermetically-sealed TO-78 package is available with full military screening per MIL-S-19500 (see Military Information).



ABSOLUTE MAXIMUM RATINGS

Gate-Drain, Gate-Source Voltage	-25 V
Gate-Gate Voltage	± 80 V
Gate Current	50 mA
Lead Temperature ($1/16$ " from case for 10 sec.)	300°C
Storage Temperature	-65 to 200°C
Operating Junction Temperature	-55 to 150°C

For applications information see AN102.

Power Dissipation :	Per Side ^a	367 mW
	Total ^b	500 mW

Notes

- a. Derate 3 mW/°C above 25°C
- b. Derate 4 mW/°C above 25°C

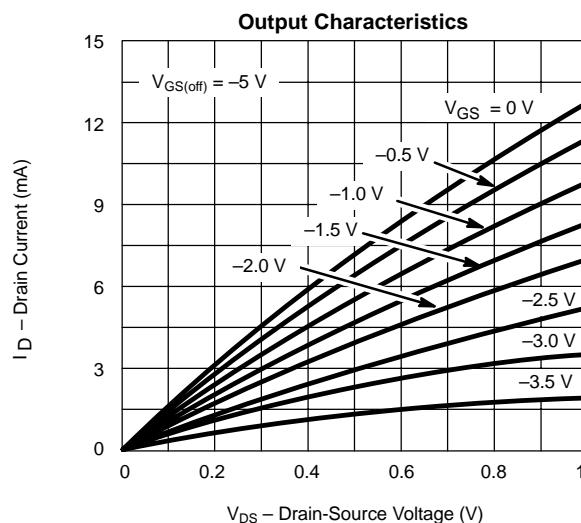
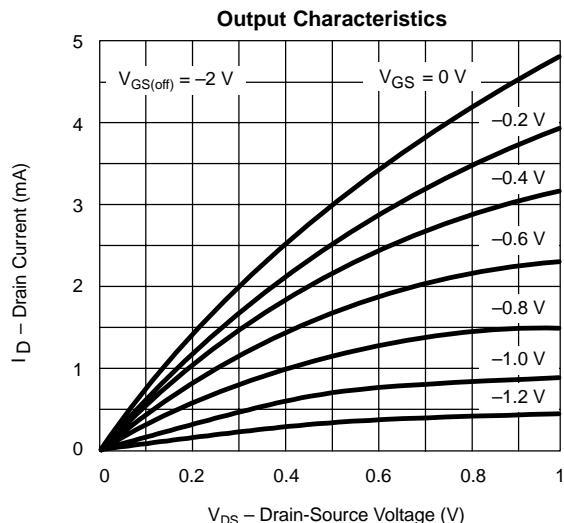
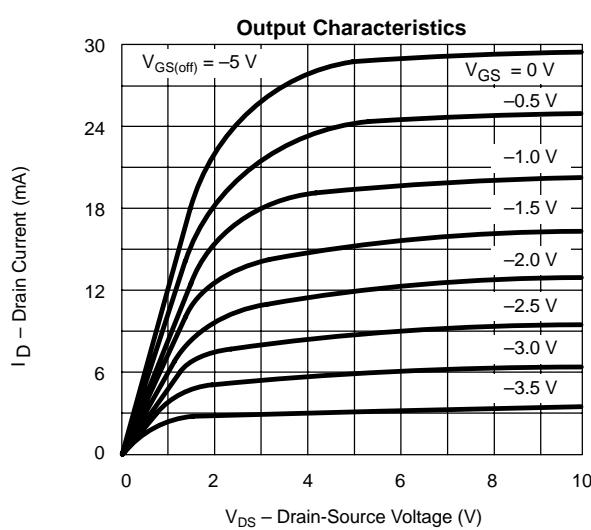
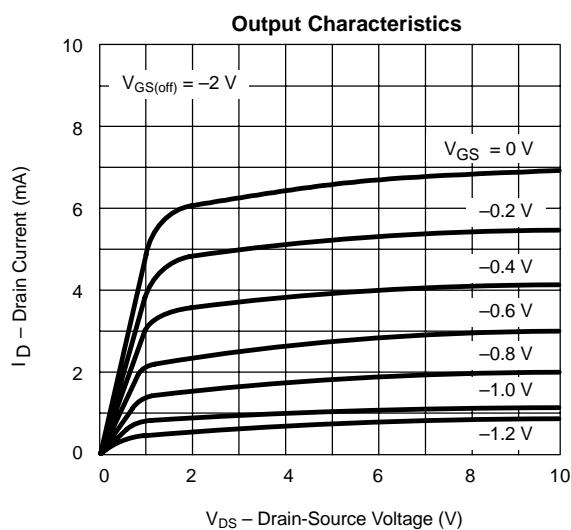
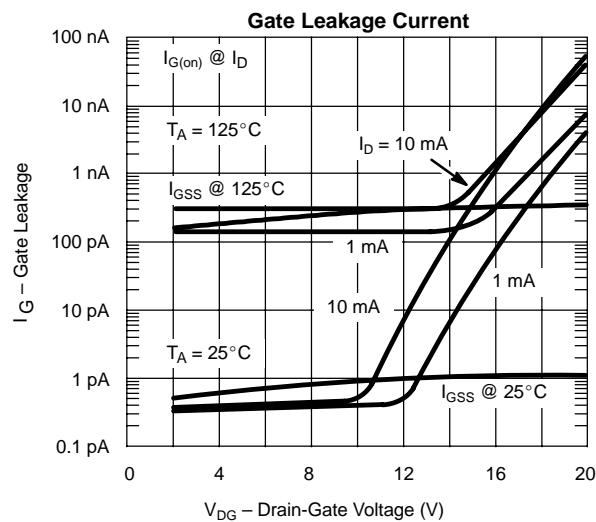
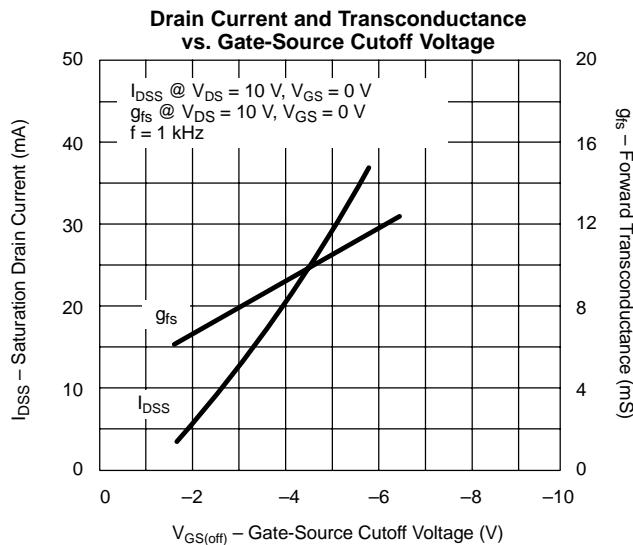
SPECIFICATIONS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)

Parameter	Symbol	Test Conditions	Typ ^a	Limits				Unit	
				2N5911		2N5912			
				Min	Max	Min	Max		
Static									
Gate-Source Breakdown Voltage	$V_{(\text{BR})\text{GSS}}$	$I_G = -1 \mu\text{A}, V_{DS} = 0 \text{ V}$	-35	-25		-25		V	
Gate-Source Cutoff Voltage	$V_{GS(\text{off})}$	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ nA}$	-3.5	-1	-5	-1	-5		
Saturation Drain Current ^b	I_{DSS}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}$	15	7	40	7	40	mA	
Gate Reverse Current	I_{GSS}	$V_{GS} = -15 \text{ V}, V_{DS} = 0 \text{ V}$ $T_A = 150^\circ\text{C}$	-1		-100		-100	pA	
Gate Operating Current	I_G	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}$ $T_A = 125^\circ\text{C}$	-1		-100		-100	pA	
Gate-Source Voltage	V_{GS}	$V_{DG} = 10 \text{ V}, I_G = 5 \text{ mA}$	-1.5	-0.3	-4	-0.3	-4	V	
Gate-Source Forward Voltage ^c	$V_{GS(F)}$	$I_G = 1 \text{ mA}, V_{DS} = 0 \text{ V}$	0.7						
Dynamic									
Common-Source Forward Transconductance	g_{fs}	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}$ $f = 1 \text{ kHz}$	6	5	10	5	10	mS	
Common-Source Output Conductance	g_{os}		70		100		100	μS	
Common-Source Forward Transconductance	g_{fs}	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}$ $f = 100 \text{ MHz}$	5.8	5	10	5	10	mS	
Common-Source Output Conductance	g_{os}		90		150		150	μS	
Common-Source Input Capacitance	C_{iss}	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}$ $f = 1 \text{ MHz}$	3		5		5	pF	
Common-Source Reverse Transfer Capacitance	C_{rss}		1		1.2		1.2		
Equivalent Input Noise Voltage	\bar{e}_n	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}$ $f = 10 \text{ kHz}$	4		20		20	$\frac{\text{nV}}{\sqrt{\text{Hz}}}$	
Noise Figure	NF			$R_G = 100 \text{ k}\Omega$	0.1	1	1	dB	
Matching									
Differential Gate-Source Voltage	$ V_{GS1} - V_{GS2} $	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}$	4		10		15	mV	
Gate-Source Voltage Differential Change with Temperature	$\frac{\Delta V_{GS1} - V_{GS2} }{\Delta T}$	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}$ $T_A = -55 \text{ to } 125^\circ\text{C}$	15		20		40	$\mu\text{V}/^\circ\text{C}$	
Saturation Drain Current Ratio	$\frac{I_{DSS1}}{I_{DSS2}}$	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}$	0.98	0.95	1	0.95	1		
Transconductance Ratio	$\frac{g_{fs1}}{g_{fs2}}$	$V_{DS} = 10 \text{ V}, I_D = 5 \text{ mA}$ $f = 1 \text{ kHz}$	0.98	0.95	1	0.95	1		
Differential Gate Current	$ I_{G1} - I_{G2} $	$V_{DG} = 10 \text{ V}, I_D = 5 \text{ mA}, T_A = 125^\circ\text{C}$	0.005		20		20	nA	
Common Mode Rejection Ratio ^c	CMRR	$V_{DG} = 5 \text{ to } 10 \text{ V}, I_D = 5 \text{ mA}$	85					dB	

Notes

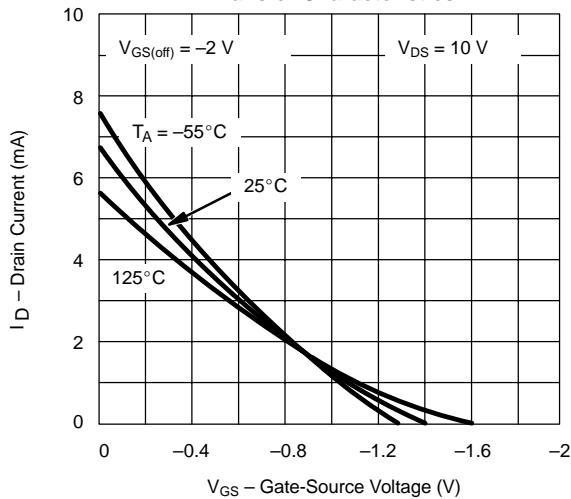
- a. Typical values are for DESIGN AID ONLY, not guaranteed nor subject to production testing.
b. Pulse test: PW $\leq 300 \mu\text{s}$ duty cycle $\leq 3\%$.
c. This parameter not registered with JEDEC.

NZF

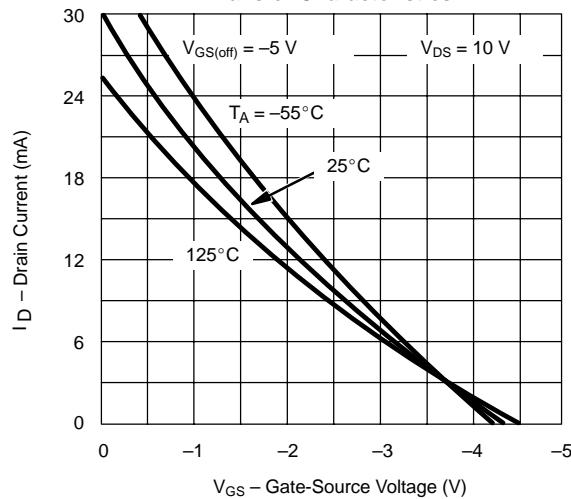
TYPICAL CHARACTERISTICS ($T_A = 25^\circ\text{C}$ UNLESS OTHERWISE NOTED)


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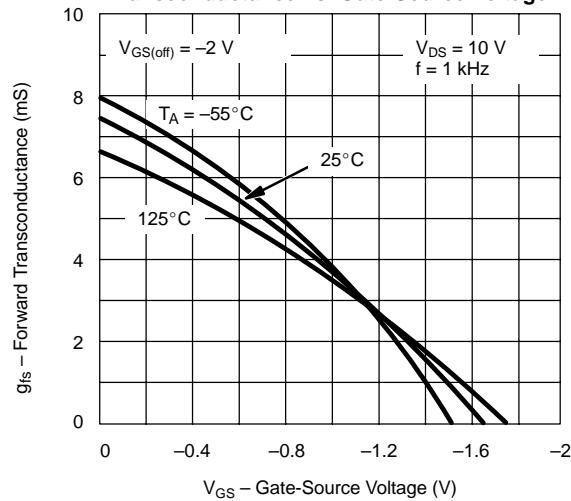
Transfer Characteristics



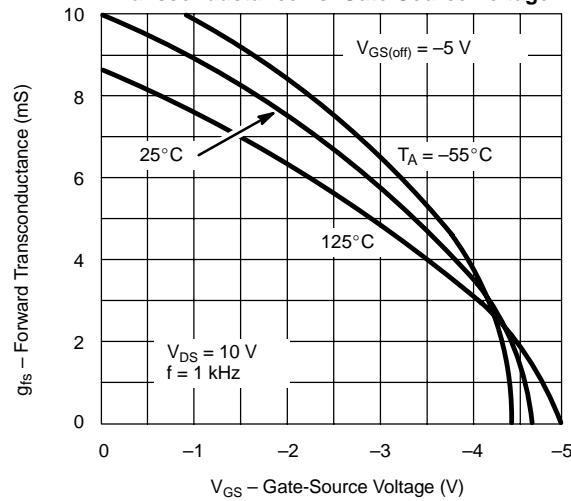
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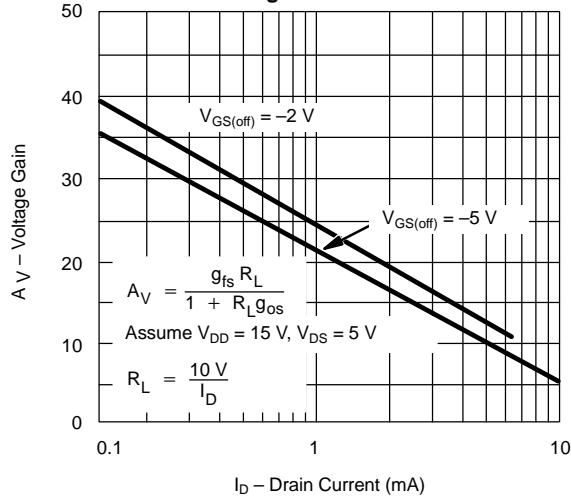
Transconductance vs. Gate-Source Voltage



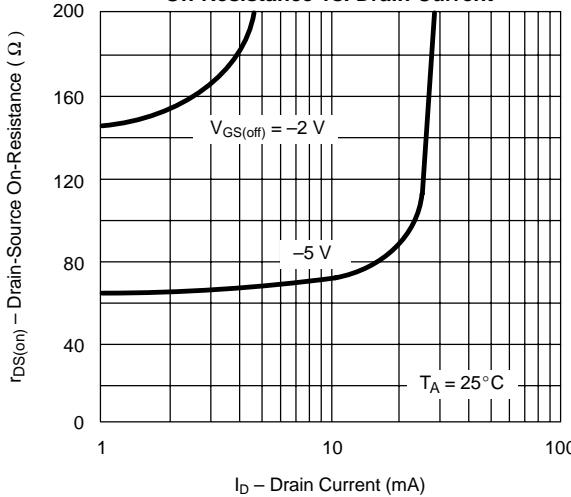
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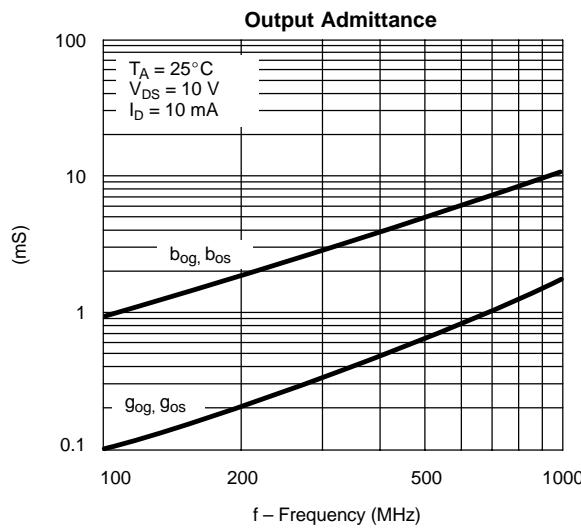
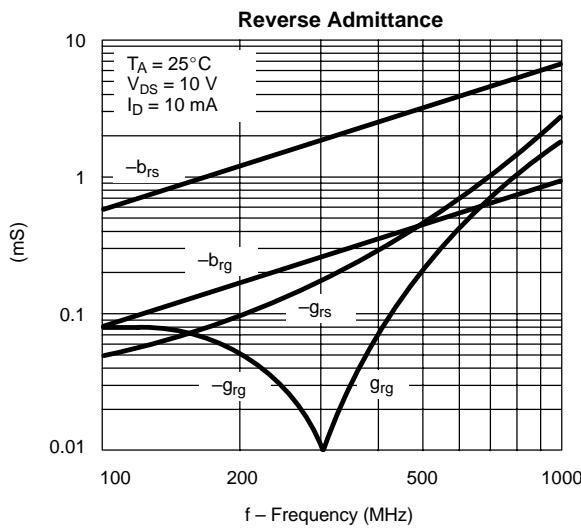
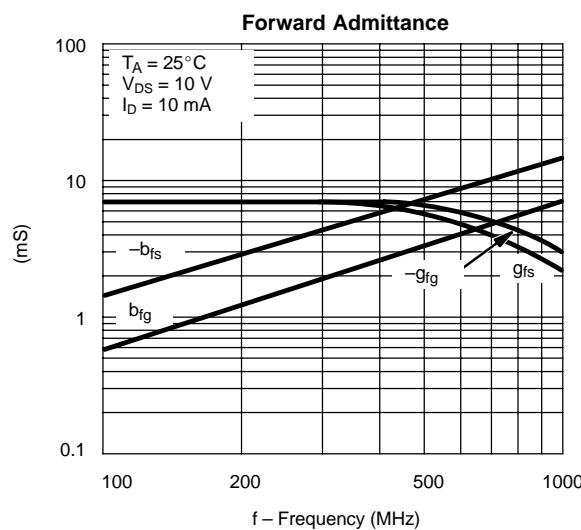
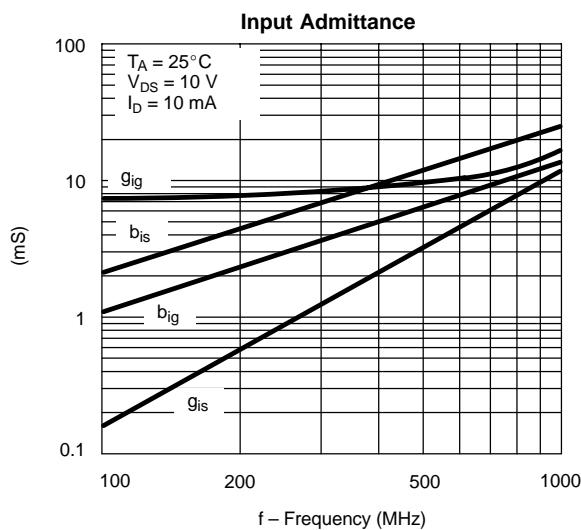
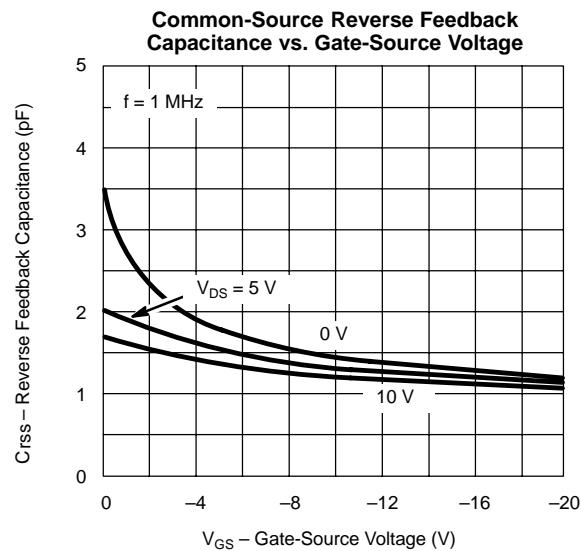
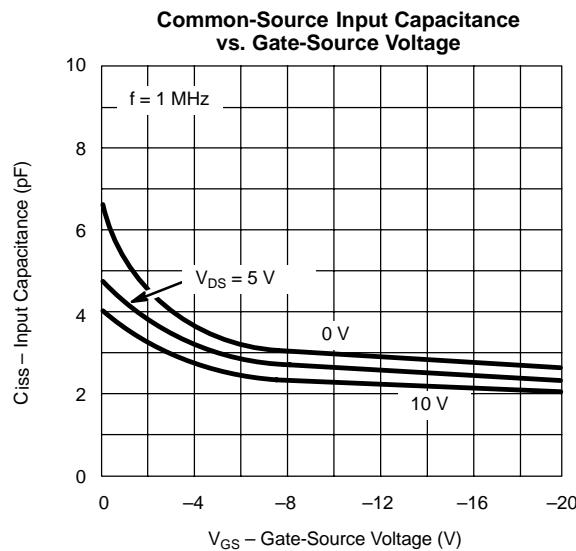


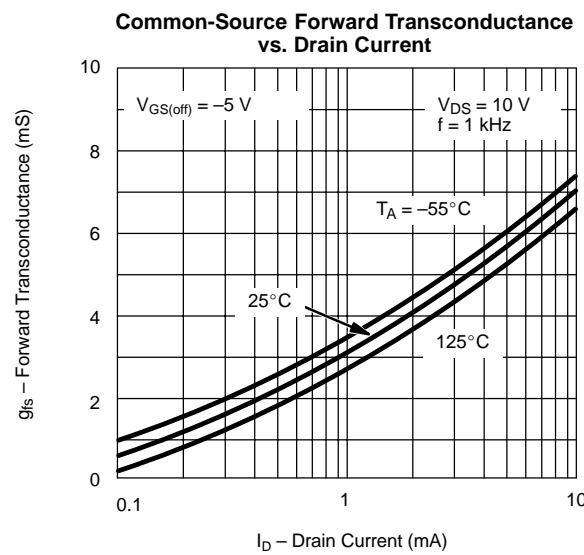
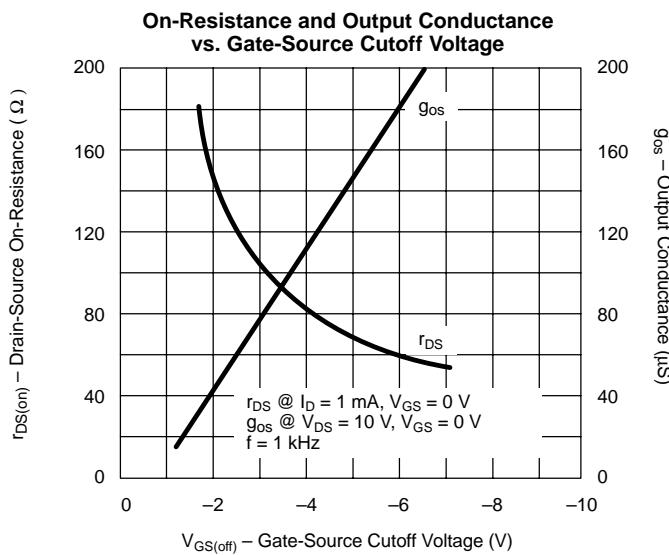
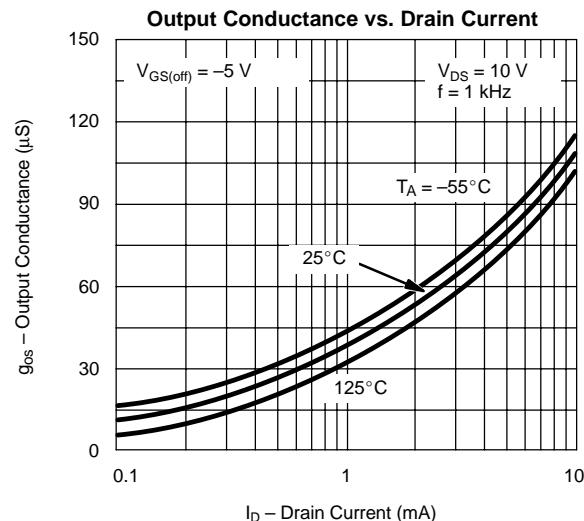
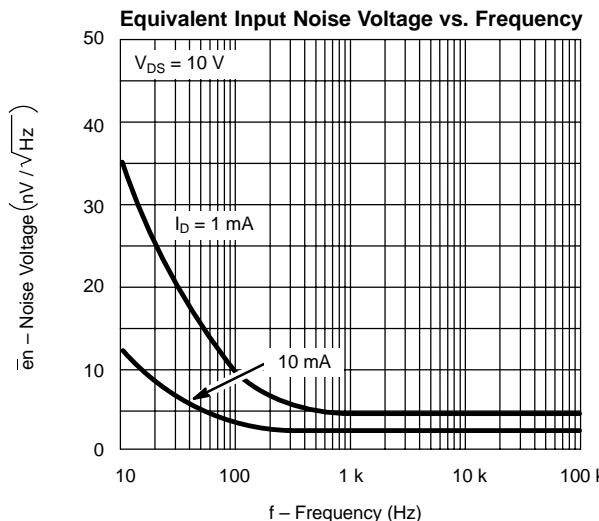
Circuit Voltage Gain vs. Drain Current



On-Resistance vs. Drain Current



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